

IF4510

N-Channel Silicon Junction Field-Effect Transistor

• Low-Noise, High Gain Amplifier

Absolute maximum ratings at $T_A = 25^\circ\text{C}$

Reverse Gate Source & Reverse Gate Drain Voltage	- 20 V
Continuous Forward Gate Current	10 mA
Continuous Device Power Dissipation	300 mW
Power Derating	1.8 mW/ $^\circ\text{C}$
Storage Temperature Range	- 65 $^\circ\text{C}$ to 200 $^\circ\text{C}$

At 25°C free air temperature:

Static Electrical Characteristics

	IF4510		Process NJ450H		
	Min	Max	Unit	Test Conditions	
Gate Source Breakdown Voltage	$V_{(\text{BR})\text{GSS}}$	- 20	V	$I_G = - 1 \mu\text{A}$, $V_{\text{DS}} = \emptyset\text{V}$	
Gate Reverse Current	I_{GSS}		nA	$V_{\text{GS}} = - 15\text{V}$, $V_{\text{DS}} = \emptyset\text{V}$	
Gate Source Cutoff Voltage	$V_{\text{GS}(\text{OFF})}$	- 0.35	- 1.5	V	$V_{\text{DS}} = 15\text{V}$, $I_D = 0.5 \text{ nA}$
Drain Saturation Current (Pulsed)	I_{DSS}	5	mA	$V_{\text{DS}} = 15\text{V}$, $V_{\text{GS}} = \emptyset\text{V}$	

Dynamic Electrical Characteristics

Common Source Forward Transconductance	g_{fs}	15		mS	$V_{\text{DS}} = 15\text{V}$, $I_D = 5 \text{ mA}$	$f = 1 \text{ kHz}$
Common Source Input Capacitance	C_{iss}		35	pF	$V_{\text{DS}} = 15\text{V}$, $V_{\text{GS}} = \emptyset\text{V}$	$f = 1 \text{ MHz}$
Common Source Reverse Transfer Capacitance	C_{rss}		8	pF	$V_{\text{DS}} = 15\text{V}$, $V_{\text{GS}} = \emptyset\text{V}$	$f = 1 \text{ MHz}$

Typ

Equivalent Short Circuit Input Noise Voltage	\bar{e}_N	1.5	nV/ $\sqrt{\text{Hz}}$	$V_{\text{DG}} = 12\text{V}$, $V_{\text{GS}} = \emptyset\text{V}$	$f = 1 \text{ kHz}$
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TO-236AB Package
Dimensions in Inches (mm)

Pin Configuration
1 Drain, 2 Source, 3 Gate